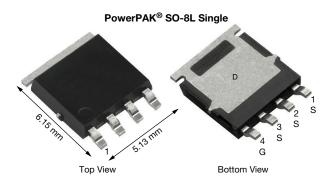
Vishay Siliconix

N-Channel 40 V (D-S) MOSFET



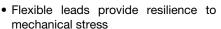
PRODUCT SUMMARY				
V _{DS} (V)	40			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$	0.00265			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5 \text{ V}$	0.00395			
Q _g typ. (nC)	18.5			
I _D (A) ^a	109			
Configuration	Single			

ORDERING INFORMATION

Lead (Pb)-free and halogen-free

FEATURES

- TrenchFET® Gen IV power MOSFET
- Very low Q_g and Q_{oss} reduce power loss and improve efficiency



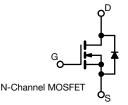


- 100 % R_a and UIS tested
- Q_{gd}/Q_{gs} ratio < 1 optimizes switching characteristics
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

APPLICATIONS

- Synchronous rectification
- High power density DC/DC
- DC/AC inverters

PowerPAK SO-8L SiJA58ADP-T1-GE3



PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V_{DS}	40	V	
Gate-source voltage		V_{GS}	+20, -16	¬	
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		109		
	T _C = 70 °C		87.3		
	T _A = 25 °C	I _D	32.3 ^{b, c}		
	T _A = 70 °C		25.9 b, c		
Pulsed drain current (t = 100 μs)		I _{DM}	150	A	
Continuous source-drain diode current	T _C = 25 °C	1	51.6		
	T _A = 25 °C	I _S	4.5 b, c		
Single pulse avalanche current	1 0111	I _{AS}	30		
Single pulse avalanche energy	L = 0.1 mH	E _{AS}	45	mJ	
Maximum power dissipation	T _C = 25 °C		56.8	w	
	T _C = 70 °C	-	36.3		
	T _A = 25 °C	P _D	5 b, c		
	T _A = 70 °C		3.2 b, c		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	90	
Soldering recommendations (peak temperature) d, e			260	°C	

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient b, f	t ≤ 10 s	R _{thJA}	20	25	°C/W	
Maximum junction-to-case (drain)	Steady state	R_{thJC}	1.7	2.2	G/VV	

Notes

- a. $T_C = 25$ °C
- b. Surface mounted on 1" x 1" FR4 board
- c. t = 10 s
- d. See solder profile (<u>www.vishay.com/doc?73257</u>). The PowerPAK SO-8L is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components
- f. Maximum under steady state conditions is 70 °C/W

Vishay Siliconix

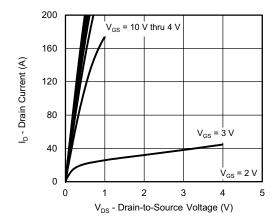
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static	<u> </u>						
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	40	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$		-	25	-	mV/°C	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-6	-		
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.1	-	2.4	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +20, -16 \text{ V}$	-	-	± 100	nA	
Zero gate voltage drain current		$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	μА	
	I _{DSS}	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	-	-	10		
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30	-	-	Α	
B.:	_ ` ´	V _{GS} = 10 V, I _D = 15 A	-	0.00220	0.00265	Ω	
Drain-source on-state resistance a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$	-	0.00330	0.00395		
Forward transconductance a	9 _{fs}	V _{DS} = 10 V, I _D = 15 A	-	80	-	S	
Dynamic ^b		·		•			
Input capacitance	C _{iss}		-	3030	-	pF	
Output capacitance	C _{oss}	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz	-	550	-		
Reverse transfer capacitance	C _{rss}		-	52	-		
C _{rss} /C _{iss} ratio			-	0.018	0.036		
otal gate charge	Q _g	$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$	-	40.5	61		
			-	18.5	28		
Gate-source charge	Q _{gs}	$V_{DS} = 20 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$	-	9.3	-	nC	
Gate-drain charge	Q _{qd}	20 . 00	_	2.8	-		
Output charge	Q _{oss}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$	-	21.5	-		
Gate resistance	R _q	f = 1 MHz	0.5	1.4	2.5	Ω	
Turn-on delay time	t _{d(on)}		-	13	26		
Rise time	t _r	$V_{DD} = 20 \text{ V}, \text{ R}_L = 2 \Omega$ $I_D \cong 10 \text{ A}, \text{ V}_{GEN} = 10 \text{ V}, \text{ R}_g = 1 \Omega$	-	5	10		
Turn-off delay time	t _{d(off)}		-	30	60		
Fall time	t _f		_	5	10		
Turn-on delay time	t _{d(on)}		-	28	56	ns	
Rise time	t _r	$V_{DD} = 20 \text{ V}, R_1 = 2 \Omega$	-	60	120		
Turn-off delay time	t _{d(off)}	$I_D \cong 10 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	-	30	60		
Fall time	t _f		-	10	20		
Drain-Source Body Diode Characteristic	:s						
Continuous source-drain diode current	Is	T _C = 25 °C	-	-	51.6	А	
Pulse diode forward current (t _p = 100 μs)	I _{SM}		-	-	150		
Body diode voltage	V _{SD}	I _S = 5 A	-	0.73	1.1	V	
Body diode reverse recovery time	t _{rr}	-	-	29	58	ns	
Body diode reverse recovery charge	Q _{rr}	$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	17	34	nC	
Reverse recovery fall time	t _a	T _J = 25 °C	-	14	-	ns	
Reverse recovery rise time	t _b		-	15	-		

Notes

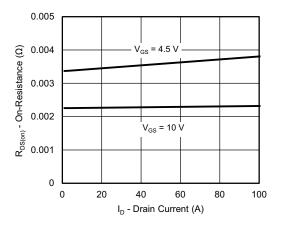
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

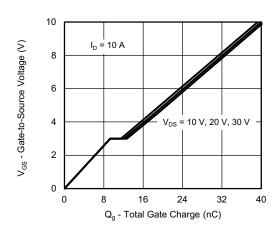




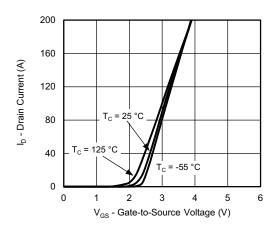
Output Characteristics



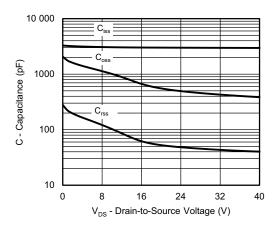
On-Resistance vs. Drain Current



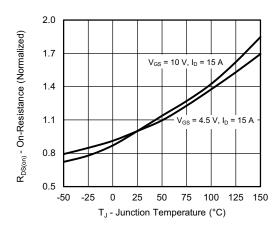
Gate Charge



Transfer Characteristics

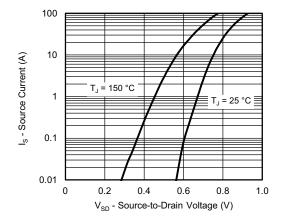


Capacitance

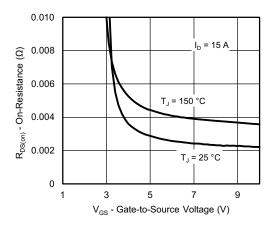


On-Resistance vs. Junction Temperature

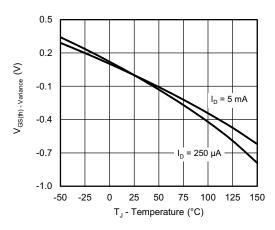




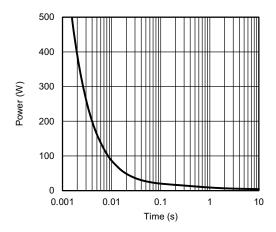
Source-Drain Diode Forward Voltage



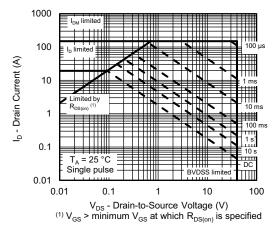
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

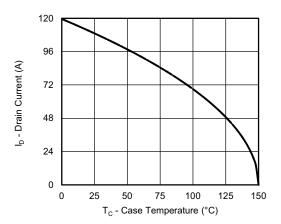


Single Pulse Power, Junction-to-Ambient

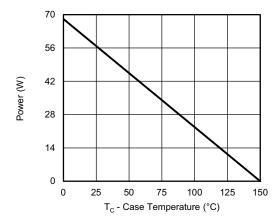


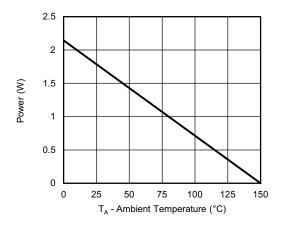
Safe Operating Area





Current Derating a





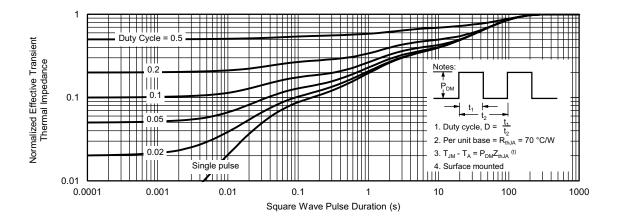
Power, Junction-to-Case

Power, Junction-to-Ambient

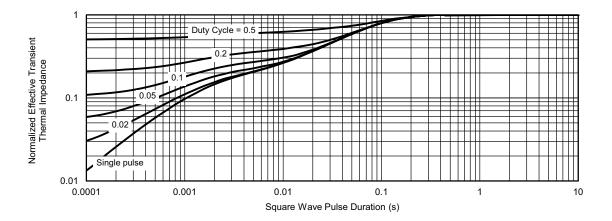
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient

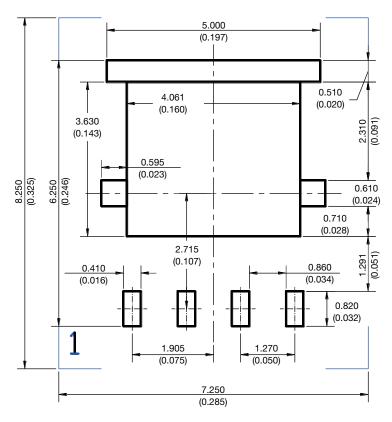


Normalized Thermal Transient Impedance, Junction-to-Case

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RECOMMENDED MINIMUM PAD FOR PowerPAK® SO-8L SINGLE



Recommended Minimum Pads Dimensions in mm (inches)



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Vishay

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